

Search Notes  	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/699,331	PARK ET AL.
	Examiner	Art Unit
	Michael t. Tran	2827

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
365	185.18	9/14/05	AEY
365	185.22	9/14/05	AEY